

FEATURES

Rx mixer with integrated fractional-N PLL
RF input frequency range: 1200 MHz to 3600 MHz
Internal LO frequency range: 2500 MHz to 2900 MHz
Input P1dB: 14.5 dBm
Input IP3: 27.5 dBm
IIP3 optimization via external pin
SSB noise figure
 IP3SET pin open: 14.3 dB
 IP3SET pin at 3.3 V: 15.5 dB
Voltage conversion gain: 6.8 dB
Matched 200 Ω IF output impedance
IF 3 dB bandwidth: 500 MHz
Programmable via 3-wire SPI interface
40-lead, 6 mm $\times$ 6 mm LFCSP

APPLICATIONS

Cellular base stations

GENERAL DESCRIPTION

The ADRF6604 is a high dynamic range active mixer with integrated phase-locked loop (PLL) and voltage controlled oscillator (VCO). The PLL/synthesizer uses a fractional-N PLL to generate a f_{LO} input to the mixer. The reference input can be divided or multiplied and then applied to the PLL phase frequency detector (PFD).

The PLL can support input reference frequencies from 12 MHz to 160 MHz. The PFD output controls a charge pump whose output drives an off-chip loop filter.

The loop filter output is then applied to an integrated VCO. The VCO output at $2 \times f_{LO}$ is applied to an LO divider, as well as to a programmable PLL divider. The programmable PLL divider is controlled by a sigma-delta (Σ - Δ) modulator (SDM). The modulus of the SDM can be programmed from 1 to 2047.

The active mixer converts the single-ended, 50 Ω RF input to a differential, 200 Ω IF output. The IF output can operate up to 500 MHz.

The ADRF6604 is fabricated using an advanced silicon-germanium BiCMOS process. It is available in a 40-lead, RoHS-compliant, 6 mm $\times$ 6 mm LFCSP with an exposed paddle. Performance is specified over the -40°C to $+85^{\circ}\text{C}$ temperature range.

Table 1.

Part No.	Internal LO Range	± 3 dB RF _{IN} Balun Range	± 1 dB RF _{IN} Balun Range
ADRF6601	750 MHz	300 MHz	450 MHz
	1160 MHz	2500 MHz	1600 MHz
ADRF6602	1550 MHz	1000 MHz	1350 MHz
	2150 MHz	3100 MHz	2750 MHz
ADRF6603	2100 MHz	1100 MHz	1450 MHz
	2600 MHz	3200 MHz	2850 MHz
ADRF6604	2500 MHz	1200 MHz	1600 MHz
	2900 MHz	3600 MHz	3200 MHz

FUNCTIONAL BLOCK DIAGRAM

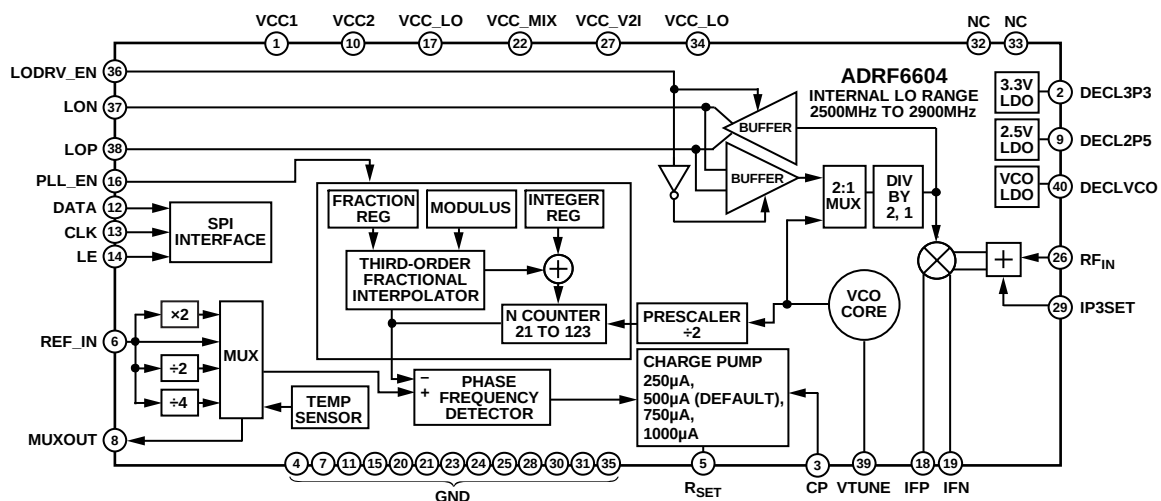


Figure 1.

Rev. B

Document Feedback

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REVISION HISTORY

1/14—Rev. A to Rev. B

Change to Product Title	1
Updated Outline Dimensions (Lead-to-Pad Dimension)	29

5/11—Rev. 0 to Rev. A

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Changes to Table 2	3
Changes to Synthesizer Specifications Parameter and to Phase Noise Parameter, Table 3	4
Changes to Power Supplies Parameter, Table 4	4
Replaced Typical Performance Characteristics Section; Renumbered Sequentially	9
Added Spurious Performance Section	15
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6/10—Revision 0: Initial Version

SPECIFICATIONS

RF SPECIFICATIONS

$V_S = 5\text{ V}$, ambient temperature (T_A) = 25°C , $f_{\text{REF}} = 153.6\text{ MHz}$, $f_{\text{PFD}} = 38.4\text{ MHz}$, high-side LO injection, $f_{\text{IF}} = 140\text{ MHz}$, IIP3 optimized using CDAC = 0xC and IP3SET = 3.3 V, unless otherwise noted.

Table 2.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
INTERNAL LO FREQUENCY RANGE		2500		2900	MHz
RF INPUT FREQUENCY RANGE	$\pm 3\text{ dB}$ RF input range	1200		3600	MHz
RF INPUT AT 2360 MHz					
Input Return Loss	Relative to $50\ \Omega$ (can be improved with external match)		−16.2		dB
Input P1dB			14.6		dBm
Second-Order Intercept (IIP2)	−5 dBm each tone (10 MHz spacing between tones)		54.5		dBm
Third-Order Intercept (IIP3)	−5 dBm each tone (10 MHz spacing between tones)		28		dBm
Single-Sideband Noise Figure	IP3SET = 3.3 V		14.8		dB
	IP3SET = open		13.9		dB
LO-to-IF Leakage	At $1\times$ LO frequency, $50\ \Omega$ termination at the RF port		−43		dBm
RF INPUT AT 2560 MHz					
Input Return Loss	Relative to $50\ \Omega$ (can be improved with external match)		−21		dB
Input P1dB			14.5		dBm
Second-Order Intercept (IIP2)	−5 dBm each tone (10 MHz spacing between tones)		58.2		dBm
Third-Order Intercept (IIP3)	−5 dBm each tone (10 MHz spacing between tones)		27.6		dBm
Single-Sideband Noise Figure	IP3SET = 3.3 V		14.9		dB
	IP3SET = open		14.2		dB
LO-to-IF Leakage	At $1\times$ LO frequency, $50\ \Omega$ termination at the RF port		−42		dBm
RF INPUT AT 2760 MHz					
Input Return Loss	Relative to $50\ \Omega$ (can be improved with external match)		−20		dB
Input P1dB			14.4		dBm
Second-Order Intercept (IIP2)	−5 dBm each tone (10 MHz spacing between tones)		64.4		dBm
Third-Order Intercept (IIP3)	−5 dBm each tone (10 MHz spacing between tones)		27		dBm
Single-Sideband Noise Figure	IP3SET = 3.3 V		15.5		dB
	IP3SET = open		14.6		dB
LO-to-IF Leakage	At $1\times$ LO frequency, $50\ \Omega$ termination at the RF port		−44		dBm
IF OUTPUT					
Voltage Conversion Gain	Differential $200\ \Omega$ load		6.8		dB
IF Bandwidth	Small signal 3 dB bandwidth		500		MHz
Output Common-Mode Voltage	External pull-up balun or inductors required		5		V
Gain Flatness	Over frequency range, any 5 MHz/50 MHz		0.2/0.5		dB
Gain Variation	Over full temperature range		1.3		dB
Output Swing	Differential $200\ \Omega$ load		2		V p-p
Output Return Loss	Relative to $200\ \Omega$		−15		dB
LO INPUT/OUTPUT (LOP, LON)	Externally applied $1\times$ LO input, internal PLL disabled				
Frequency Range		250		6000	MHz
Output Level (LO as Output)	$1\times$ LO into a $50\ \Omega$ load, LO output buffer enabled		−9		dBm
Input Level (LO as Input)		−6	0	+6	dBm
Input Impedance			50		Ω

SYNTHESIZER/PLL SPECIFICATIONS

$V_S = 5\text{ V}$, ambient temperature (T_A) = 25°C , $f_{\text{REF}} = 153.6\text{ MHz}$, $f_{\text{REF}} \text{ power} = 4\text{ dBm}$, $f_{\text{PFD}} = 38.4\text{ MHz}$, high-side LO injection, $f_{\text{IF}} = 140\text{ MHz}$, IIP3 optimized using CDAC = 0xC and IP3SET = 3.3 V, unless otherwise noted.

Table 3.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
SYNTHESIZER SPECIFICATIONS	Synthesizer specifications referenced to $1 \times \text{LO}$				
Frequency Range	Internally generated LO	2500		2900	MHz
Figure of Merit ¹	$P_{\text{REF_IN}} = 0\text{ dBm}$		-221.4		dBc/Hz/Hz
Reference Spurs	$f_{\text{PFD}} = 38.4\text{ MHz}$				
	$f_{\text{PFD}}/4$		-107		dBc
	f_{PFD}		-82		dBc
	$>f_{\text{PFD}}$		-80		dBc
PHASE NOISE	$f_{\text{LO}} = 2500\text{ MHz to }2900\text{ MHz}$, $f_{\text{PFD}} = 38.4\text{ MHz}$				
	1 kHz to 10 kHz offset		-87.7		dBc/Hz
	100 kHz offset		-96		dBc/Hz
	500 kHz offset		-117		dBc/Hz
	1 MHz offset		-126		dBc/Hz
	5 MHz offset		-142		dBc/Hz
	10 MHz offset		-148		dBc/Hz
	20 MHz offset		-150		dBc/Hz
Integrated Phase Noise	1 kHz to 40 MHz integration bandwidth		0.69		°rms
PFD Frequency		20		40	MHz
REFERENCE CHARACTERISTICS	REF_IN, MUXOUT pins				
REF_IN Input Frequency		12		160	MHz
REF_IN Input Capacitance			4		pF
MUXOUT Output Level	V_{OL} (lock detect output selected)			0.25	V
	V_{OH} (lock detect output selected)	2.7			V
MUXOUT Duty Cycle			50		%
CHARGE PUMP					
Pump Current	Programmable to 250 μA , 500 μA , 750 μA , 1 mA		500		μA
Output Compliance Range		1		2.8	V

¹ The figure of merit (FOM) is computed as phase noise (dBc/Hz) – $10 \log 10(f_{\text{PFD}}) - 20 \log 10(f_{\text{LO}}/f_{\text{PFD}})$. The FOM was measured across the full LO range, with $f_{\text{REF}} = 80\text{ MHz}$, and $f_{\text{REF}} \text{ power} = 10\text{ dBm}$ (500 V/ μs slew rate) with a 40 MHz f_{PFD} . The FOM was computed at 50 kHz offset.

LOGIC INPUT AND POWER SPECIFICATIONS

$V_S = 5\text{ V}$, ambient temperature (T_A) = 25°C , $f_{\text{REF}} = 153.6\text{ MHz}$, $f_{\text{PFD}} = 38.4\text{ MHz}$, high-side LO injection, $f_{\text{IF}} = 140\text{ MHz}$, IIP3 optimized using CDAC = 0xC and IP3SET = 3.3 V, unless otherwise noted.

Table 4.

Parameter	Test Conditions/Comments	Min	Typ	Max	Unit
LOGIC INPUTS	CLK, DATA, LE				
Input High Voltage, V_{INH}		1.4		3.3	V
Input Low Voltage, V_{INL}		0		0.7	V
Input Current, $I_{\text{INH}}/I_{\text{INL}}$			0.1		μA
Input Capacitance, C_{IN}			5		pF
POWER SUPPLIES	VCC1, VCC2, VCC_LO, VCC_MIX, and VCC_V2I pins				
Voltage Range		4.75	5	5.25	V
Supply Current	PLL only		96		mA
	External LO mode (internal PLL disabled, IP3SET pin = 3.3 V, LO output buffer off)		164		mA
	Internal LO mode (internal PLL enabled, IP3SET pin = 3.3 V, LO output buffer on)		274		mA
	Internal LO mode (internal PLL enabled, IP3SET pin = 3.3 V, LO output buffer off)		260		mA
	Power-down mode		30		mA

TIMING CHARACTERISTICSVCC2 = 5 V $\pm$ 5%.

Table 5.

Parameter	Limit	Unit	Description
t ₁	20	ns min	LE setup time
t ₂	10	ns min	DATA-to-CLK setup time
t ₃	10	ns min	DATA-to-CLK hold time
t ₄	25	ns min	CLK high duration
t ₅	25	ns min	CLK low duration
t ₆	10	ns min	CLK-to-LE setup time
t ₇	20	ns min	LE pulse width

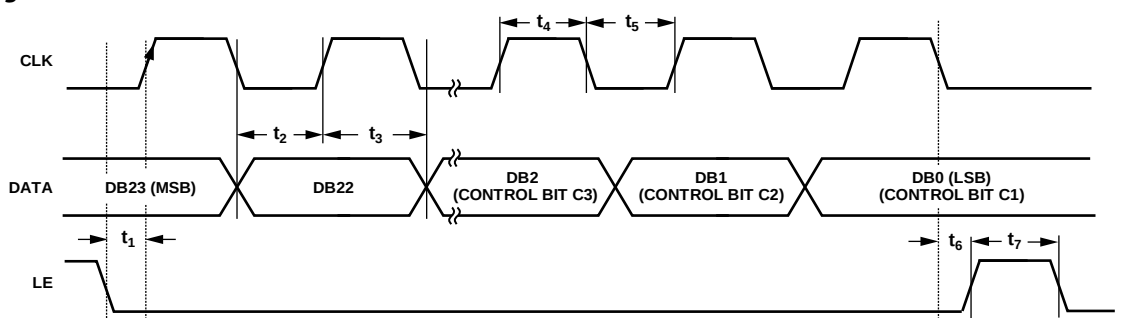
Timing Diagram

Figure 2. Timing Diagram

08553-002

ABSOLUTE MAXIMUM RATINGS

Table 6.

Parameter	Rating
Supply Voltage, VCC1, VCC2, VCC_LO, VCC_MIX, VCC_V2I	–0.5 V to +5.5 V
Digital I/O, CLK, DATA, LE, LODRV_EN, PLL_EN	–0.3 V to +3.6 V
VTUNE	0 V to 3.3 V
IFP, IFN	–0.3 V to VCC_V2I + 0.3 V
RF _{IN}	16 dBm
LOP, LON, REF_IN	13 dBm
θ _{JA} (Exposed Paddle Soldered Down)	35°C/W
Maximum Junction Temperature	150°C
Operating Temperature Range	–40°C to +85°C
Storage Temperature Range	–65°C to +150°C

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

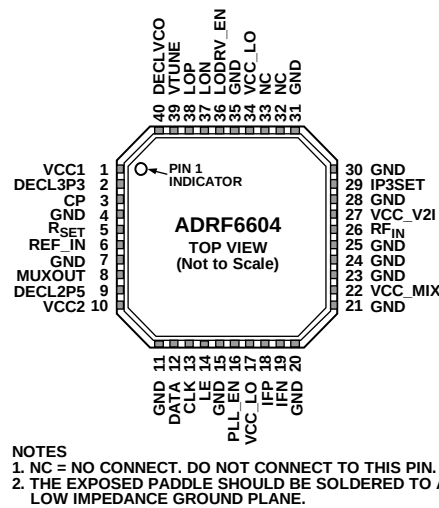


Figure 3. Pin Configuration

Table 7. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	VCC1	Power Supply for the 3.3 V LDO. Power supply voltage range is 4.75 V to 5.25 V. Each power supply pin should be decoupled with a 100 pF capacitor and a 0.1 μF capacitor located close to the pin.
2	DECL3P3	Decoupling Node for 3.3 V LDO. Connect a 0.1 μF capacitor between this pin and ground.
3	CP	Charge Pump Output Pin. Connect to VTUNE through the loop filter.
4, 7, 11, 15, 20, 21, 23, 24, 25, 28, 30, 31, 35	GND	Ground. Connect these pins to a low impedance ground plane.
5	R _{SET}	Charge Pump Current. The nominal charge pump current can be set to 250 μA, 500 μA, 750 μA, or 1 mA using Bit DB11 and Bit DB10 in Register 4 and by setting Bit DB18 in Register 4 to 0 (internal reference current). In this mode, no external R _{SET} is required. If Bit DB18 is set to 1, the four nominal charge pump currents (I _{NOMINAL}) can be externally adjusted according to the following equation: $R_{SET} = \left(\frac{217.4 \times I_{CP}}{I_{NOMINAL}} \right) - 37.8 \Omega$
6	REF_IN	Reference Input. Nominal input level is 1 V p-p. Input range is 12 MHz to 160 MHz. This pin is internally dc-biased and should be ac-coupled.
8	MUXOUT	Multiplexer Output. This output can be programmed to provide the reference output signal or the lock detect signal. The output is selected by programming the appropriate register.
9	DECL2P5	Decoupling Node for 2.5 V LDO. Connect a 0.1 μF capacitor between this pin and ground.
10	VCC2	Power Supply for the 2.5 V LDO. Power supply voltage range is 4.75 V to 5.25 V. Each power supply pin should be decoupled with a 100 pF capacitor and a 0.1 μF capacitor located close to the pin.
12	DATA	Serial Data Input. The serial data input is loaded MSB first; the three LSBs are the control bits.
13	CLK	Serial Clock Input. The serial clock input is used to clock in the serial data to the registers. The data is latched into the 24-bit shift register on the CLK rising edge. The maximum clock frequency is 20 MHz.
14	LE	Load Enable. When the LE input pin goes high, the data stored in the shift register is loaded into one of the eight registers. The relevant latch is selected by the three control bits of the 24-bit word.
16	PLL_EN	PLL Enable. Switch between internal PLL and external LO input. When this pin is logic high, the mixer LO is automatically switched to the internal PLL and the internal PLL is powered up. When this pin is logic low, the internal PLL is powered down and the external LO input is routed to the mixer LO inputs. The SPI can also be used to switch modes.
17, 34	VCC_LO	Power Supply. Power supply voltage range is 4.75 V to 5.25 V. Each power supply pin should be decoupled with a 100 pF capacitor and a 0.1 μF capacitor located close to the pin.
18, 19	IFP, IFN	Mixer IF Outputs. These outputs should be pulled to VCC_MIX with RF chokes.

Pin No.	Mnemonic	Description
22	VCC_MIX	Power Supply. Power supply voltage range is 4.75 V to 5.25 V. Each power supply pin should be decoupled with a 100 pF capacitor and a 0.1 μ F capacitor located close to the pin.
26	RF _{IN}	RF Input. Single-ended, 50 Ω .
27	VCC_V2I	Power Supply. Power supply voltage range is 4.75 V to 5.25 V. Each power supply pin should be decoupled with a 100 pF capacitor and a 0.1 μ F capacitor located close to the pin.
29	IP3SET	Connect a resistor from this pin to a 5 V supply to adjust IIP3. Normally leave open.
32, 33	NC	NC = No Connect. Do not connect to this pin.
36	LODRV_EN	LO Driver Enable. Together with Pin 16 (PLL_EN), this digital input pin determines whether the LOP and LON pins operate as inputs or outputs. LOP and LON become inputs if the PLL_EN pin is low or if the PLL_EN pin is set high with the PLEN bit (DB6 in Register 5) set to 0. LOP and LON become outputs if either the LODRV_EN pin or the LDRV bit (DB3 in Register 5) is set to 1 while the PLL_EN pin is set high. The external LO drive frequency must be 1 $\times$ LO. This pin has an internal 100 k Ω pull-down resistor.
37, 38	LON, LOP	Local Oscillator Input/Output. The internally generated 1 $\times$ LO is available on these pins. When internal LO generation is disabled, an external 1 $\times$ LO can be applied to these pins.
39	VTUNE	VCO Control Voltage Input. This pin is driven by the output of the loop filter. The nominal input voltage range on this pin is 1.5 V to 2.5 V.
40	DECLVCO	Decoupling Node for VCO LDO. Connect a 100 pF capacitor and a 10 μ F capacitor between this pin and ground.
	EPAD	Exposed Paddle. The exposed paddle should be soldered to a low impedance ground plane.

TYPICAL PERFORMANCE CHARACTERISTICS

RF FREQUENCY SWEEP

CDAC = 0xC, internally generated high-side LO, $RF_{IN} = -5$ dBm, $f_{IF} = 140$ MHz, unless otherwise noted.

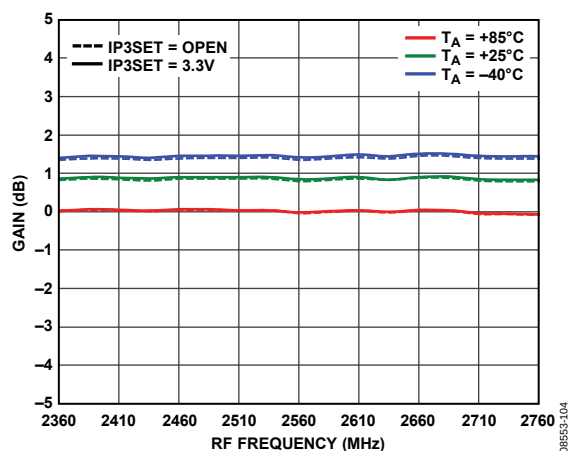


Figure 4. Gain vs. RF Frequency

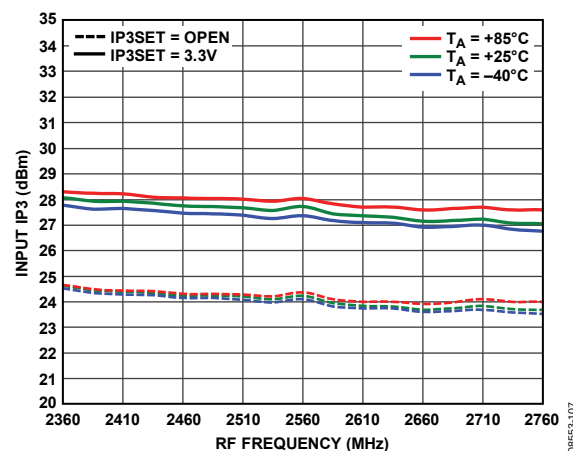


Figure 7. Input IP3 vs. RF Frequency

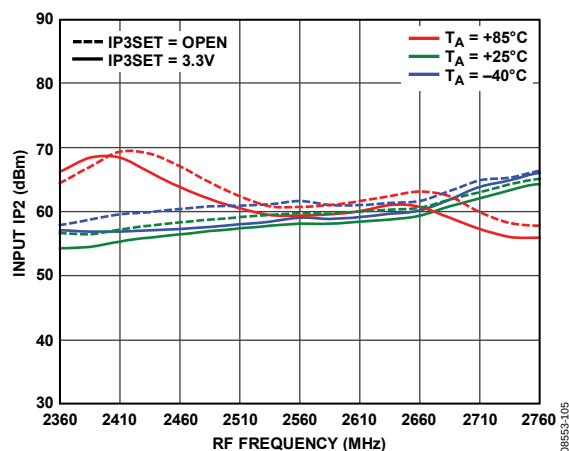


Figure 5. Input IP2 vs. RF Frequency

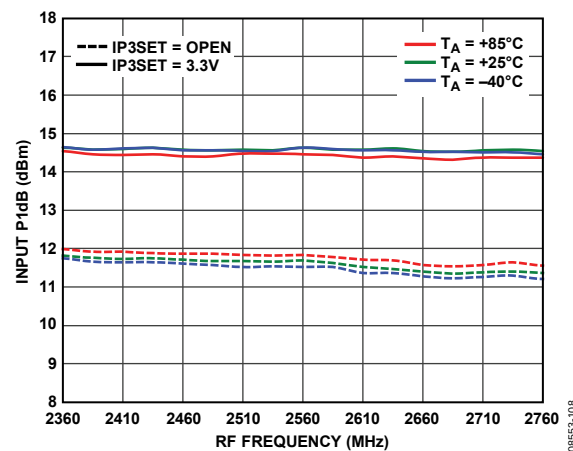


Figure 8. Input P1dB vs. RF Frequency

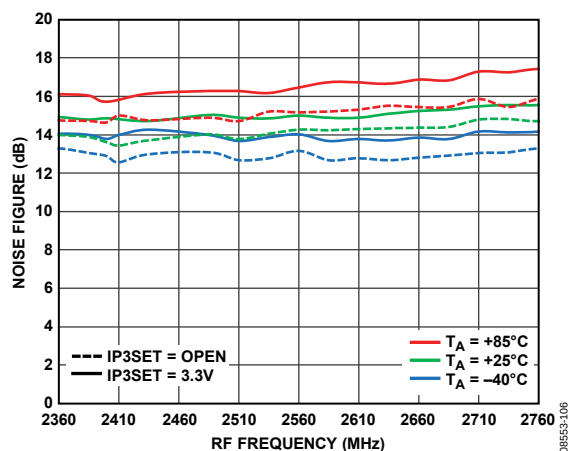


Figure 6. Noise Figure vs. RF Frequency

IF FREQUENCY SWEEP

CDAC = 0xC, internally generated swept low-side LO, $f_{RF} = 2490$ MHz, $RF_{IN} = -5$ dBm, unless otherwise noted.

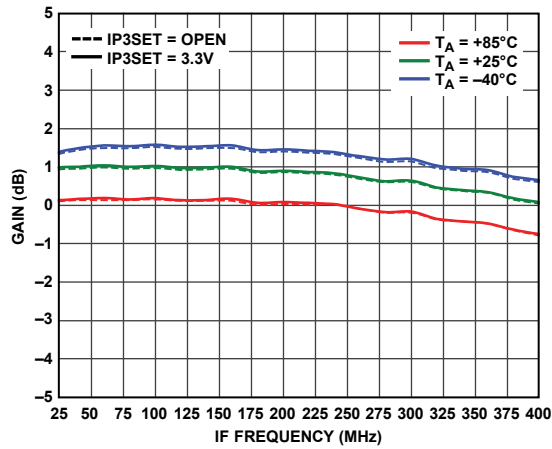


Figure 9. Gain vs. IF Frequency

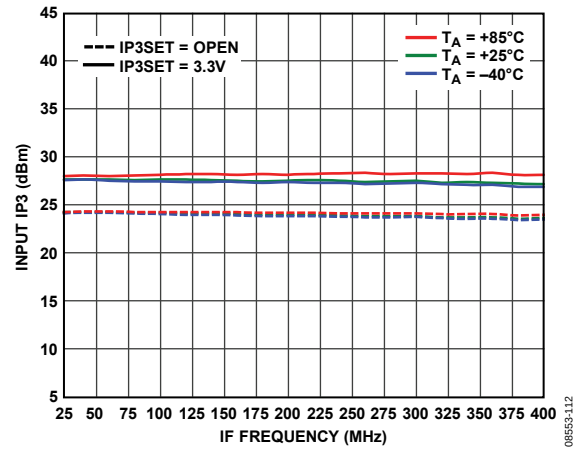
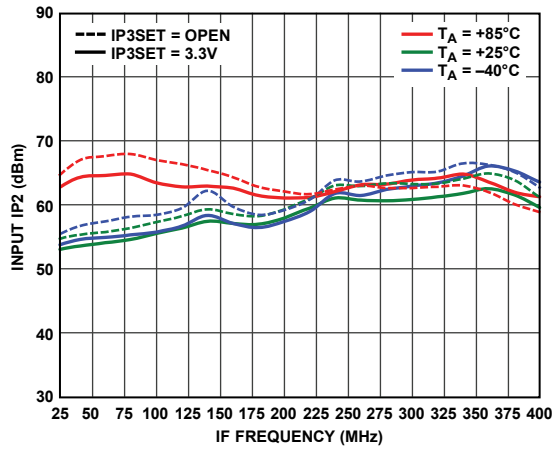
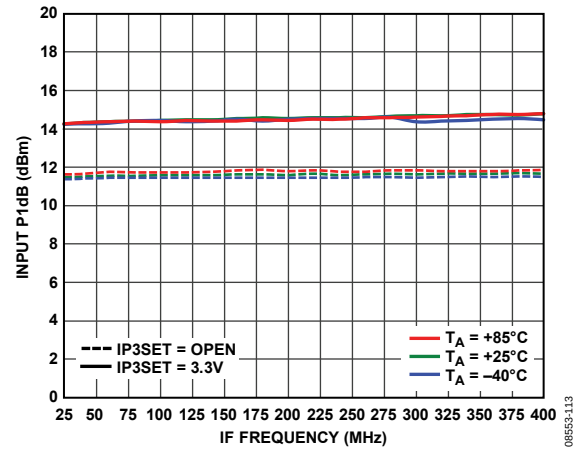
Figure 12. Input IP3 vs. IF Frequency, $RF_{IN} = -5$ dBmFigure 10. Input IP2 vs. IF Frequency, $RF_{IN} = -5$ dBm

Figure 13. Input P1dB vs. IF Frequency

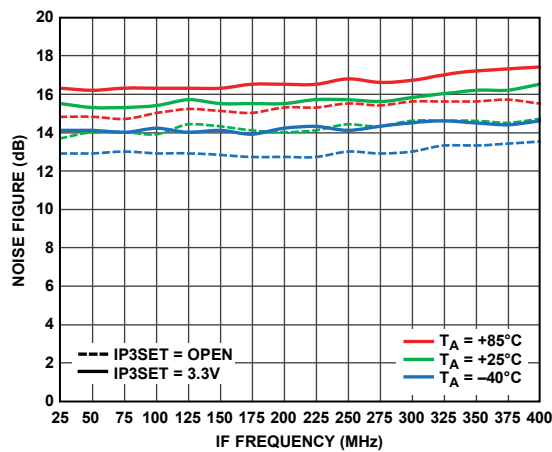


Figure 11. Noise Figure vs. IF Frequency

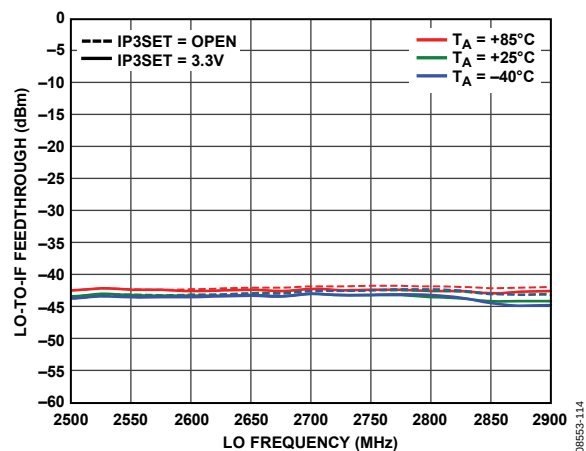


Figure 14. LO-to-IF Feedthrough vs. LO Frequency, LO Output Turned Off, CDAC = 0xC

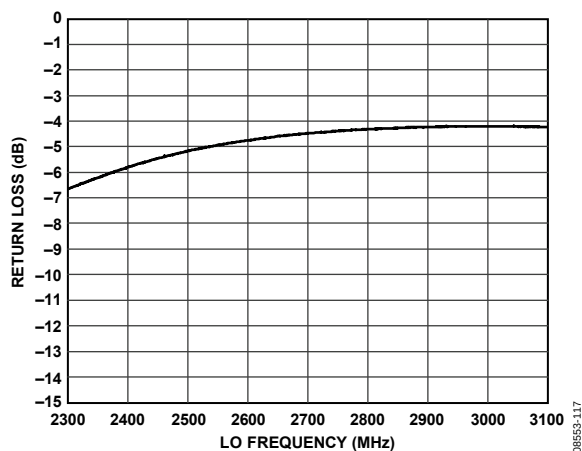


Figure 17. LO Input Return Loss vs. LO Frequency (Including TC1-1-13 Balun)

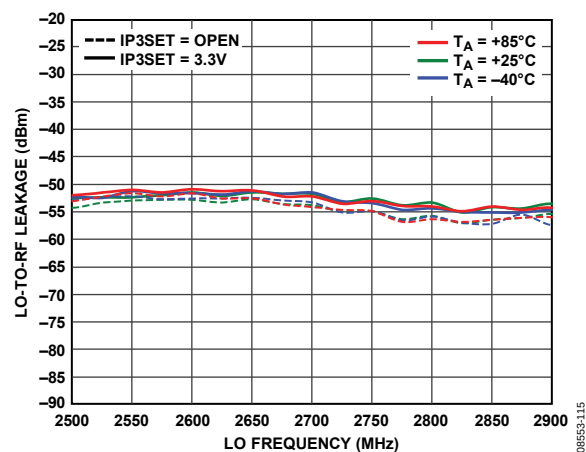


Figure 15. LO-to-RF Leakage vs. LO Frequency, LO Output Turned Off

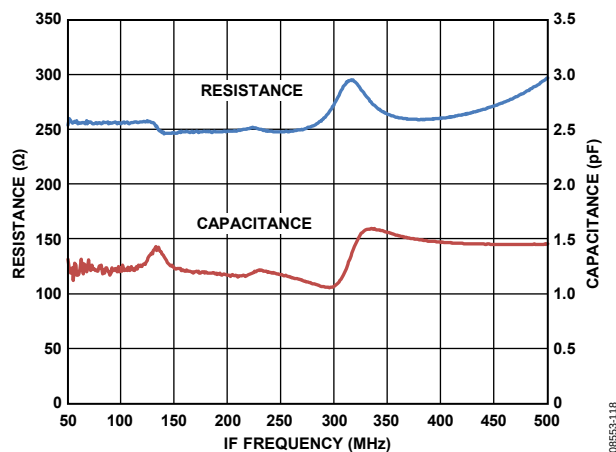


Figure 18. IF Differential Output Impedance (R Parallel, C Equivalent)

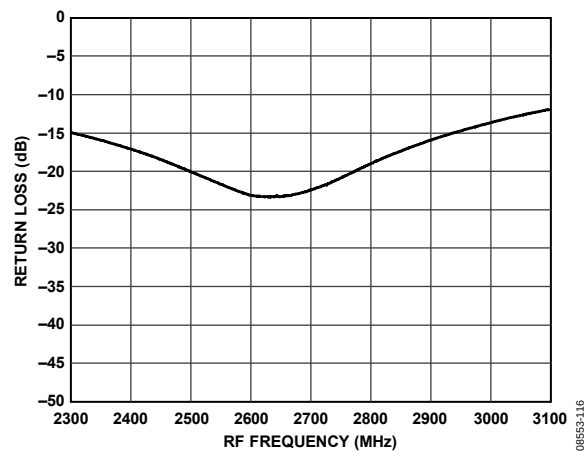


Figure 16. RF Input Return Loss vs. RF Frequency

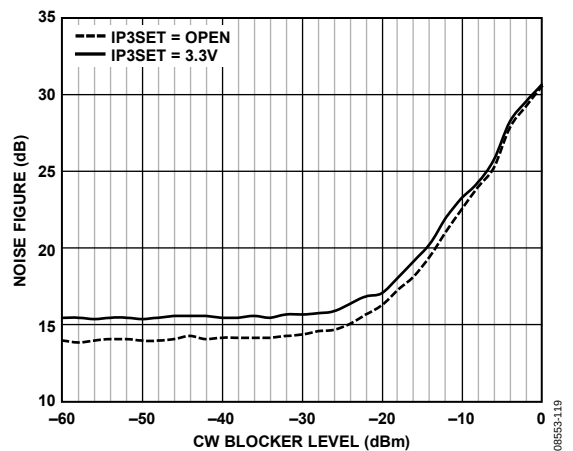


Figure 19. SSB Noise Figure vs. 5 MHz Offset CW Blocker Level, LO Frequency = 2500 MHz, RF Frequency = 2358 MHz

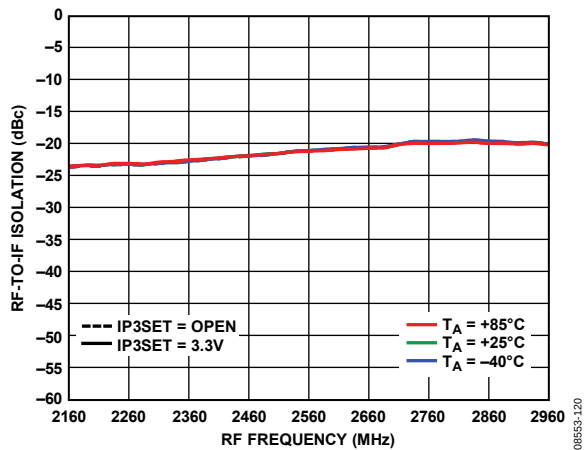


Figure 20. RF-to-IF Isolation vs. RF Frequency, High-Side LO, IF = 140 MHz, LO Output Turned Off

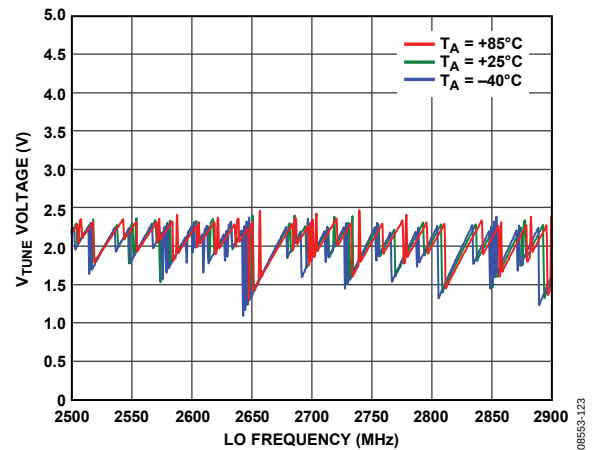


Figure 23. VTUNE vs. LO Frequency

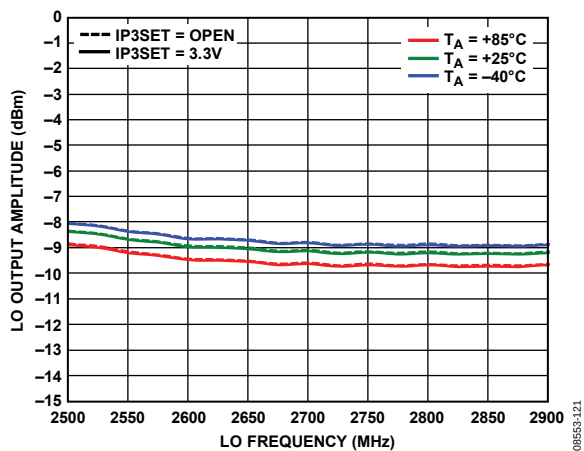


Figure 21. LO Output Amplitude vs. LO Frequency

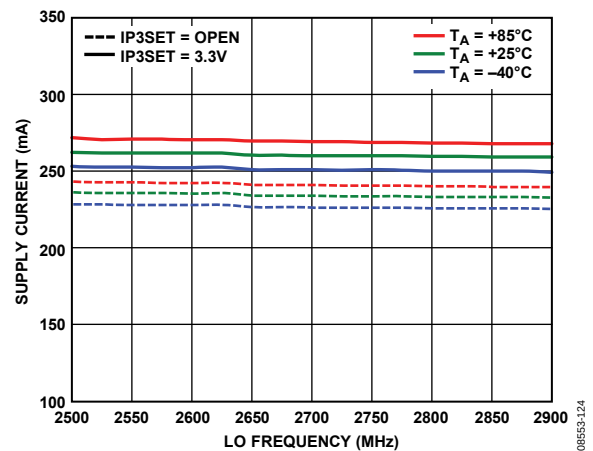


Figure 24. Supply Current vs. LO Frequency

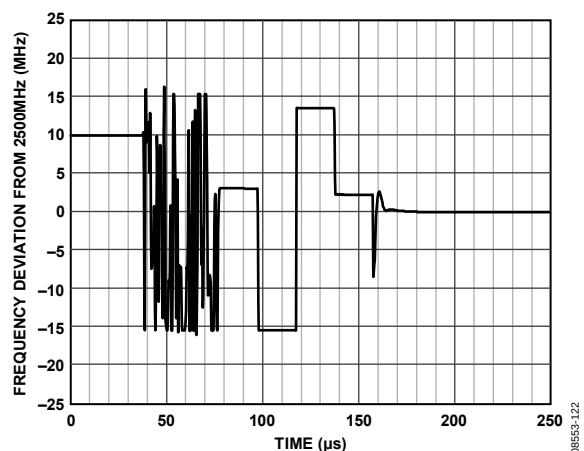


Figure 22. Frequency Deviation from 2500 MHz vs. Time
(Demonstrates LO Frequency Settling Time from 2490 MHz to 2500 MHz)

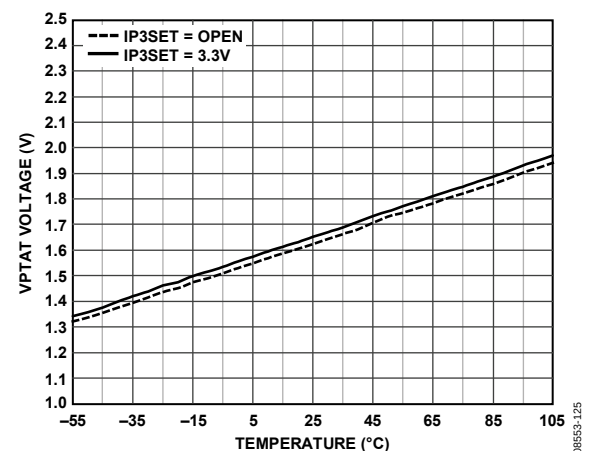


Figure 25. VPTAT Voltage vs. Temperature (IP3SET = Optimized, Open)

Complementary cumulative distribution function (CCDF), $f_{RF} = 2360$ MHz, $f_{IF} = 140$ MHz.

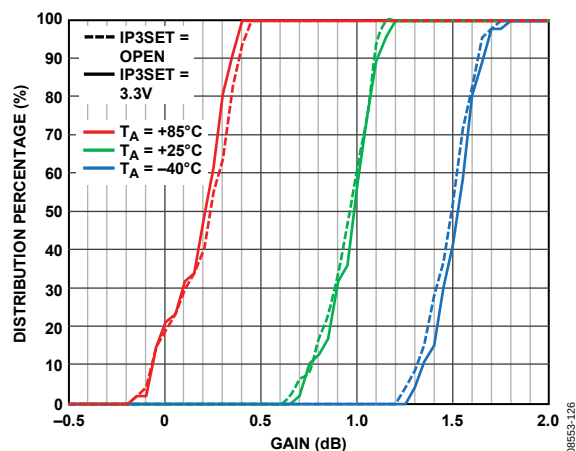


Figure 26. Gain

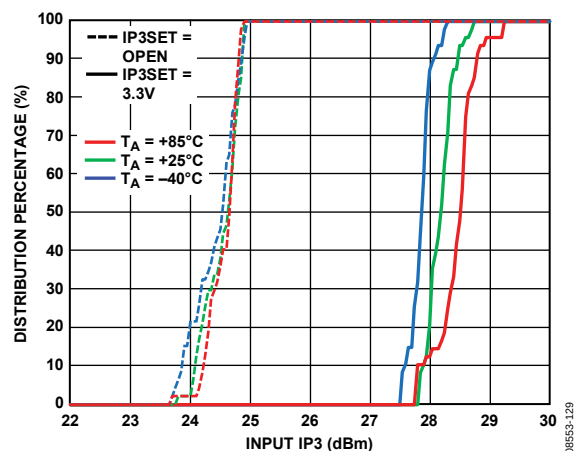


Figure 29. Input IP3

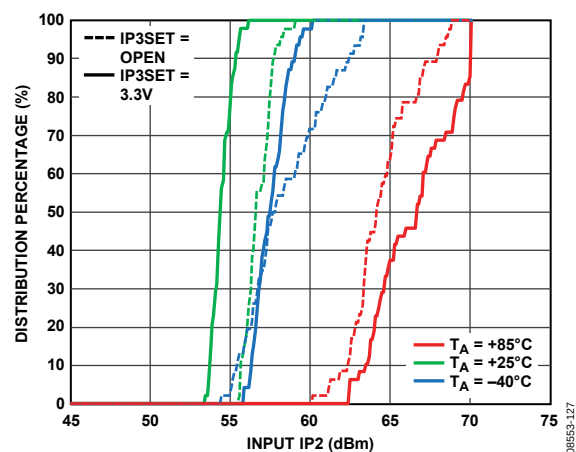


Figure 27. Input IP2

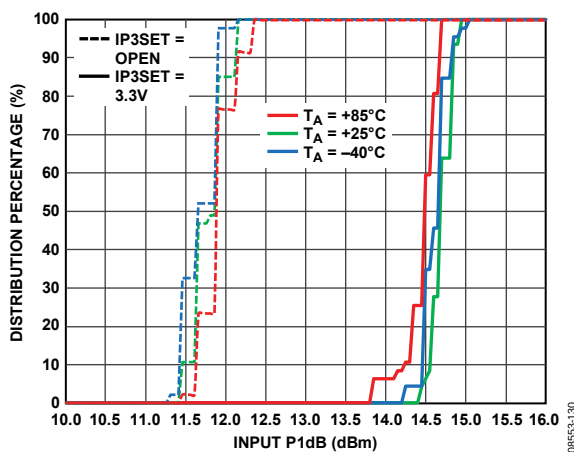


Figure 30. Input P1dB

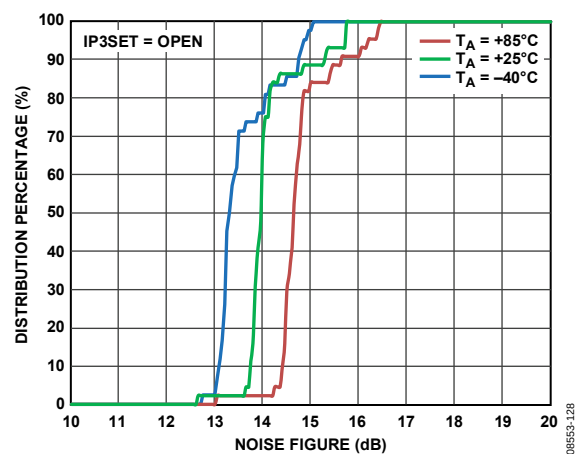


Figure 28. Noise Figure

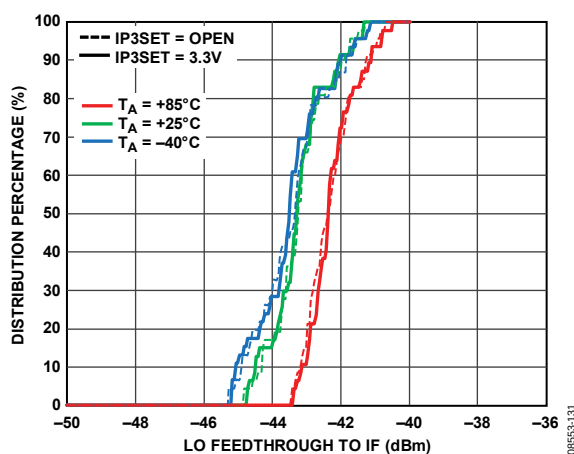


Figure 31. LO Feedthrough to IF, LO Output Turned Off

Measured at IF output, CDAC = 0xC, IP3SET = open, internally generated high-side LO, $f_{REF} = 153.6$ MHz, $f_{PFD} = 38.4$ MHz, $RF_{IN} = -5$ dBm, $f_{IF} = 140$ MHz, unless otherwise noted. Phase noise measurements made at LO output, unless otherwise noted.

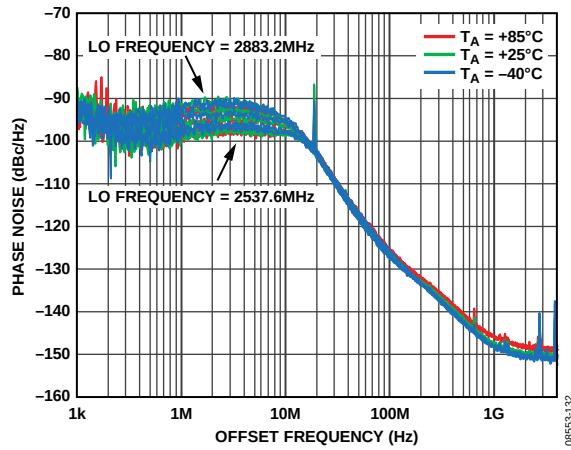


Figure 32. Phase Noise vs. Offset Frequency

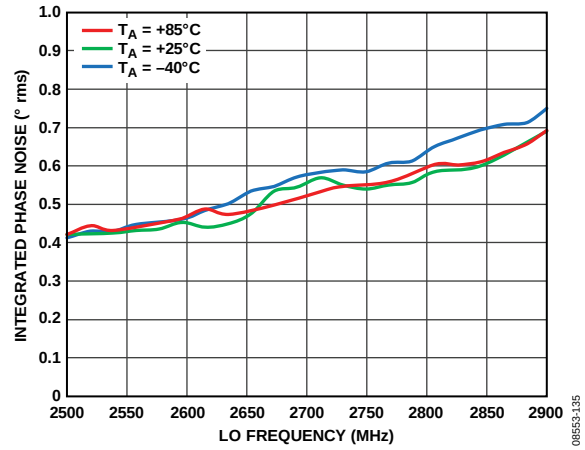


Figure 35. Integrated Phase Noise vs. LO Frequency

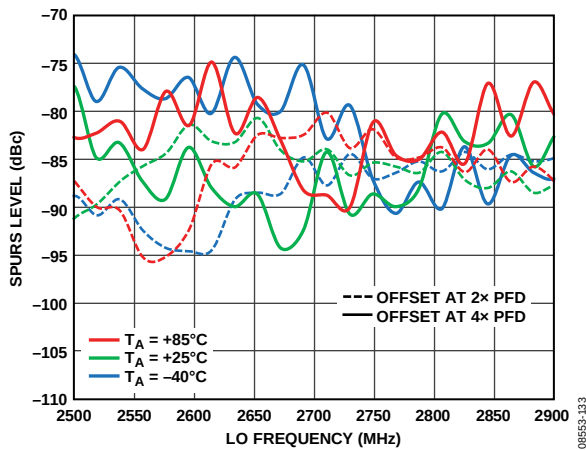


Figure 33. PLL Reference Spurs vs. LO Frequency (2x PFD and 4x PFD)

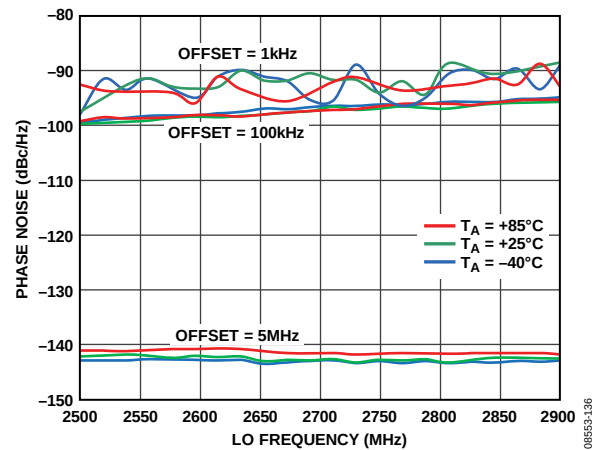


Figure 36. Phase Noise vs. LO Frequency (1 kHz, 100 kHz, and 5 MHz Steps)

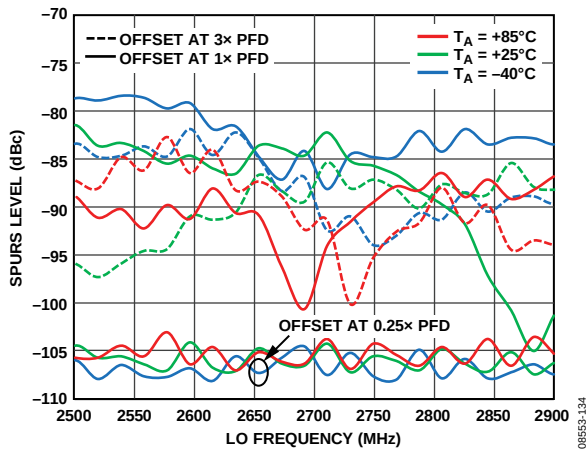


Figure 34. PLL Reference Spurs vs. LO Frequency (0.25x PFD, 1x PFD, and 3x PFD)

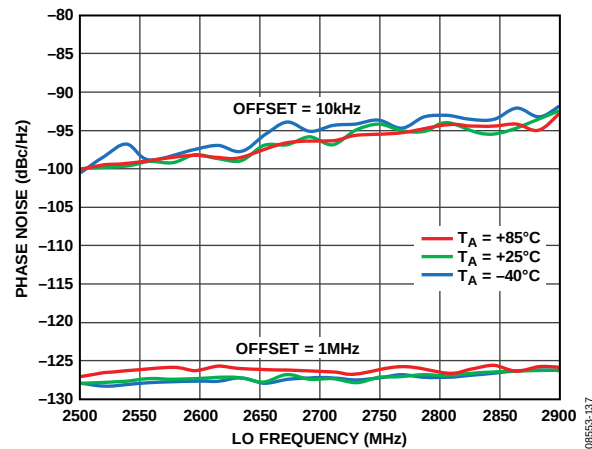


Figure 37. Phase Noise vs. LO Frequency (10 kHz, 1 MHz Steps)

SPURIOUS PERFORMANCE

$(N \times f_{RF}) - (M \times f_{LO})$ spur measurements were made using the standard evaluation board (see the Evaluation Board section). Mixer spurious products were measured in decibels relative to the carrier (dBc) from the IF output power level. All spurious components greater than -125 dBc are shown.

LO = 2500 MHz, RF = 2360 MHz (horizontal axis is M, vertical axis is N), and RF_{IN} power = 0 dBm.

		M				
N		0	1	2	3	4
	0	-115.19	-43.0184	-33.3455		
	1	-23.6708	0.0	-67.1671	-47.1921	
	2	-63.4281	-65.1191	-61.1065	-79.8957	-80.0324
	3		-83.6746	-86.8944	-58.5001	-105.514
	4			-108.708	-104.041	-108.518
	5				-110.825	-113.19
	6					-108.548
	7					

LO = 2700 MHz, RF = 2560 MHz (horizontal axis is M, vertical axis is N), and RF_{IN} power = 0 dBm.

		M				
N		0	1	2	3	4
	0	-114.804	-42.7987	-31.9174		
	1	-22.6289	0.0	-65.0063	-48.5279	
	2	-61.2522	-66.5602	-57.5224	-77.0905	-76.8305
	3		-84.4436	-82.5056	-56.9437	-98.8811
	4			-108.087	-98.5103	-99.2295
	5				-110.572	-113.601
	6					-109.829
	7					

LO = 2900 MHz, RF = 2760 MHz (horizontal axis is M, vertical axis is N), and RF_{IN} power = 0 dBm.

		M				
N		0	1	2	3	4
	0	-114.956	-44.0336	-31.2423		
	1	-22.092	0.0	-62.6978	-48.9358	
	2	-60.2824	-69.8043	-56.7826	-73.218	
	3		-85.957	-80.7407	-56.7503	-105.061
	4			-108.949	-100.938	-100.159
	5				-110.193	-111.146
	6					-111.428
	7					

REGISTER STRUCTURE

This section provides the register maps for the [ADRF6604](#). The three LSBs determine the register that is programmed.

REGISTER 0—INTEGER DIVIDE CONTROL (DEFAULT: 0x0001C0)

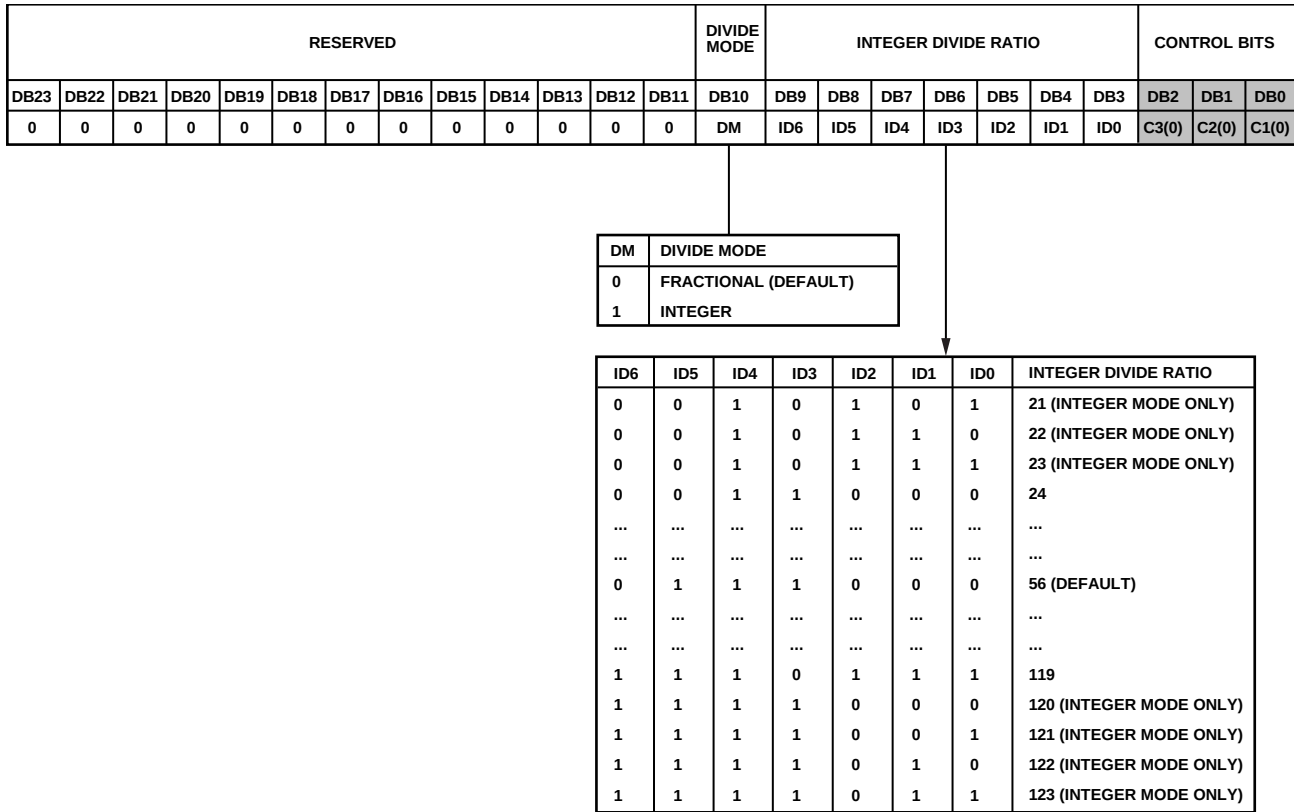


Figure 38. Register 0—Integer Divide Control Register Map

REGISTER 1—MODULUS DIVIDE CONTROL (DEFAULT: 0x003001)

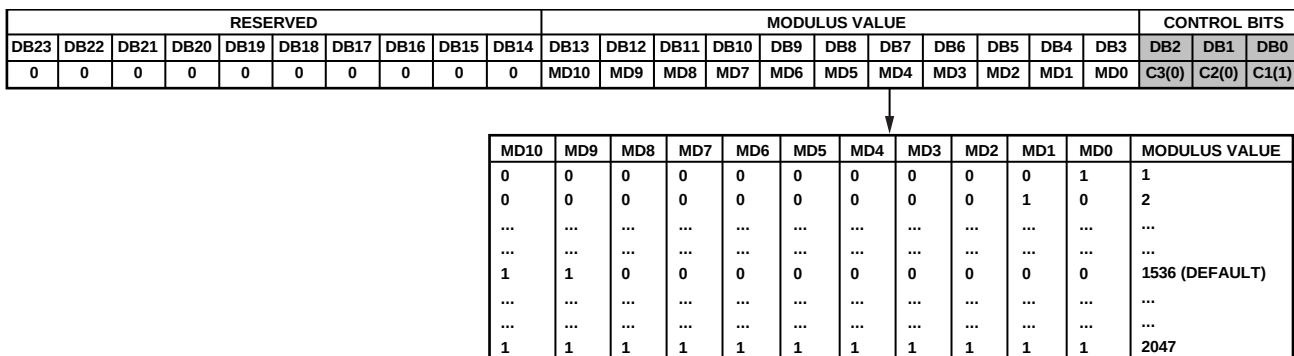


Figure 39. Register 1—Modulus Divide Control Register Map

REGISTER 2—FRACTIONAL DIVIDE CONTROL (DEFAULT: 0x001802)

RESERVED										FRACTIONAL VALUE										CONTROL BITS			
DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
0	0	0	0	0	0	0	0	0	0	FD10	FD9	FD8	FD7	FD6	FD5	FD4	FD3	FD2	FD1	FD0	C3(0)	C2(1)	C1(0)

FD10	FD9	FD8	FD7	FD6	FD5	FD4	FD3	FD2	FD1	FD0	FRACTIONAL VALUE
0	0	0	0	0	0	0	0	0	0	0	768 (DEFAULT)
0	0	0	0	0	0	0	0	0	0	1	
...	...	...	...	...	...	...	...	...	...	...	
...	...	...	...	...	...	...	...	...	...	...	
0	1	1	0	0	0	0	0	0	0	0	
...	...	...	...	...	...	...	...	...	...	...	
...	...	...	...	...	...	...	...	...	...	...	
FRACTIONAL VALUE MUST BE LESS THAN MODULUS											<MDR

08553-006

Figure 40. Register 2—Fractional Divide Control Register Map

REGISTER 3— Σ - Δ MODULATOR DITHER CONTROL (DEFAULT: 0x10000B)

DITHER MAGNITUDE			DITHER ENABLE	DITHER RESTART VALUE																		CONTROL BITS		
DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0	
0	DITH1	DITH0	DEN	DV16	DV15	DV14	DV13	DV12	DV11	DV10	DV9	DV8	DV7	DV6	DV5	DV4	DV3	DV2	DV1	DV0	C3(0)	C2(1)	C1(1)	

DITH1	DITH0	DITHER MAGNITUDE
0	0	15 (DEFAULT)
0	1	7
1	0	3
1	1	1 (RECOMMENDED)

DEN	DITHER ENABLE
0	DISABLE
1	ENABLE (DEFAULT, RECOMMENDED)

DV16	DV15	DV14	DV13	DV12	DV11	DV10	DV9	DV8	DV7	DV6	DV5	DV4	DV3	DV2	DV1	DV0	DITHER RESTART VALUE
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0x00001 (DEFAULT)
...	...	...	...	...	...	...	...	...	...	...	...	...	...	...	...	...	...
...	...	...	...	...	...	...	...	...	...	...	...	...	...	...	...	...	...
1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	0x1FFFF

08553-007

Figure 41. Register 3— Σ - Δ Modulator Dither Control Register Map

REGISTER 4—PLL CHARGE PUMP, PFD, AND REFERENCE PATH CONTROL (DEFAULT: 0x0AA7E4)

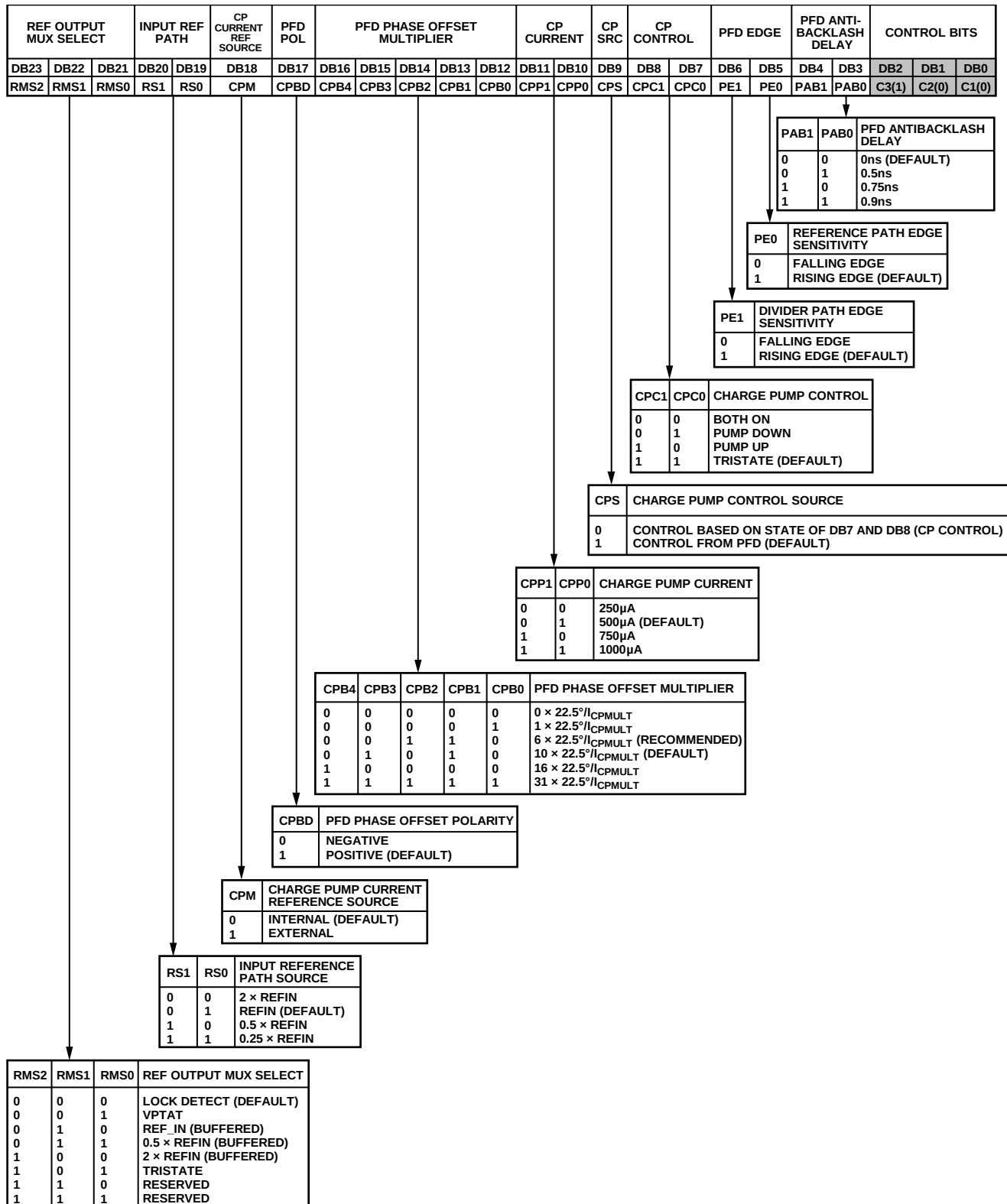


Figure 42. Register 4—PLL Charge Pump, PFD, and Reference Path Control Register Map

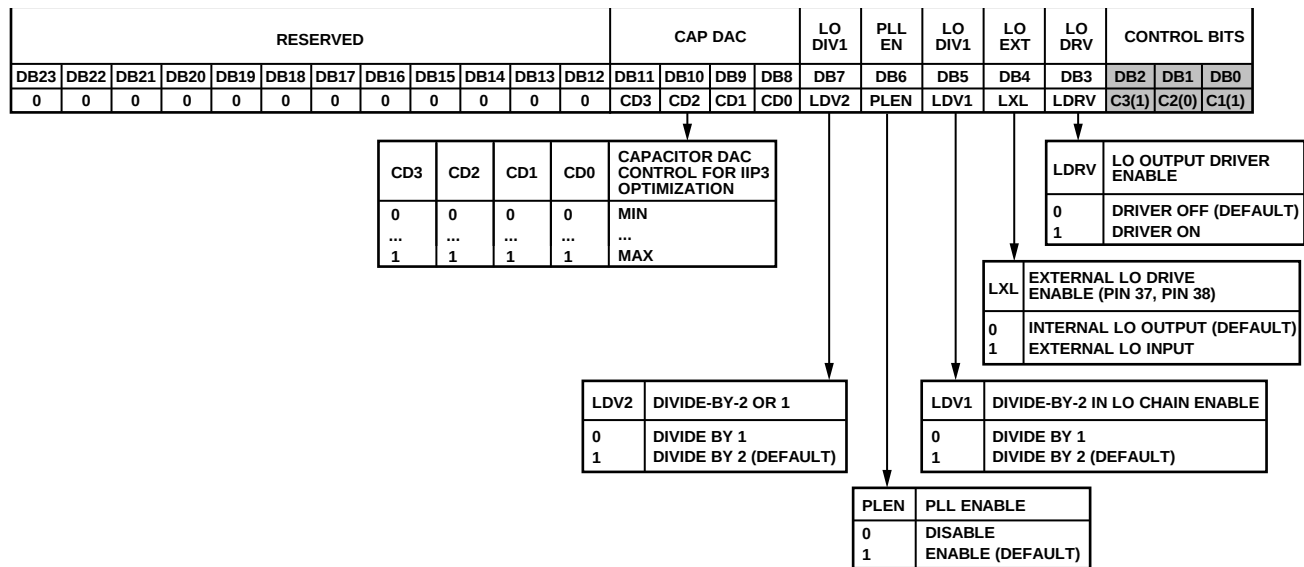
REGISTER 5—PLL ENABLE AND LO PATH CONTROL (DEFAULT: 0x0000E5)

Figure 43. Register 5—PLL Enable and LO Path Control Register Map

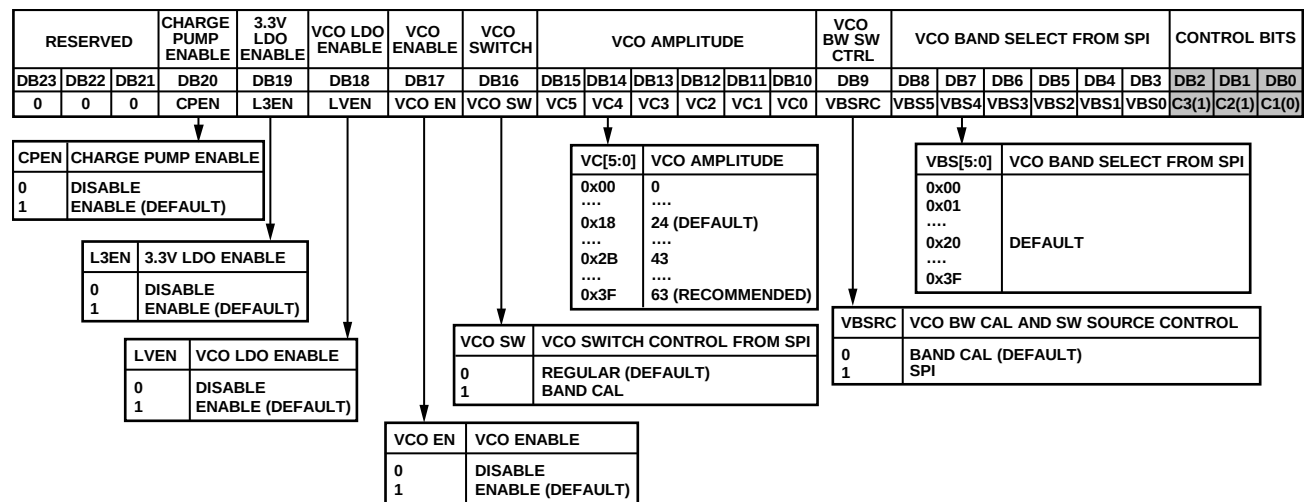
REGISTER 6—VCO CONTROL AND VCO ENABLE (DEFAULT: 0x1E2106)

Figure 44. Register 6—VCO Control and VCO Enable Register Map

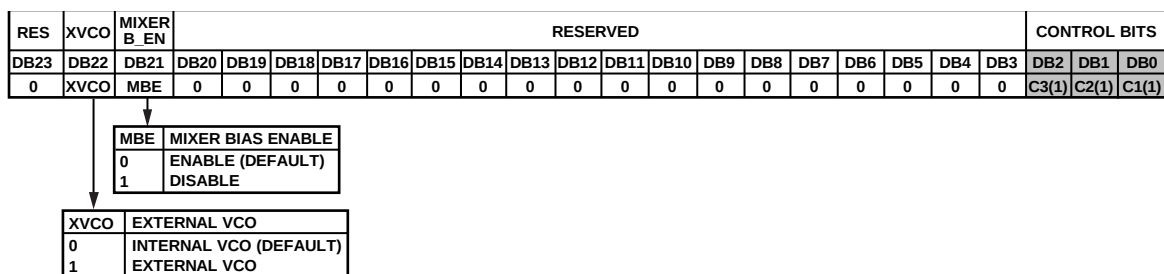
REGISTER 7—MIXER BIAS ENABLE AND EXTERNAL VCO ENABLE (DEFAULT: 0x000007)

Figure 45. Register 7—Mixer Bias Enable and External VCO Enable Register Map

THEORY OF OPERATION

The [ADRF6604](#) integrates a high performance downconverting mixer with a state-of-the-art fractional-N PLL. The PLL also integrates a low noise VCO. The SPI port allows the user to control the fractional-N PLL functions and the mixer optimization functions, as well as allowing for an externally applied LO or VCO.

The mixer core within the [ADRF6604](#) is the next generation of an industry-leading family of mixers from Analog Devices, Inc. The RF input is converted to a current and then mixed down to IF using high performance NPN transistors. The mixer output currents are transformed to a differential output. The high performance active mixer core results in an exceptional IIP3 and IP1dB with a very low output noise floor for excellent dynamic range. Over the specified frequency range, the [ADRF6604](#) typically provides IF input P1dB of 14.5 dBm and IIP3 of 27.5 dBm.

Improved performance at specific frequencies can be achieved with the use of the internal capacitor DAC (CDAC), which is programmable via the SPI port, and by using a resistor to a 5 V supply from the IP3SET pin (Pin 29). Adjustment of the capacitor DAC allows increments in phase shift at internal nodes in the [ADRF6604](#), thus allowing cancellation of third-order distortion with no change in supply current. Connecting a resistor to a 5 V supply from the IP3SET pin increases the internal mixer core current, thereby improving overall IIP2 and IIP3, as well as IP1dB. Using the IP3SET pin for this purpose increases the overall supply current.

The fractional divide function of the PLL allows the frequency multiplication value from REF_IN to LO output to be a fractional value rather than to be restricted to an integer value as in traditional PLLs. In operation, this multiplication value is

$$INT + (FRAC/MOD)$$

where:

INT is the integer value.

FRAC is the fractional value.

MOD is the modulus value.

The INT, FRAC, and MOD values are all programmable via the SPI port. In other fractional-N PLL designs, fractional multiplication is achieved by periodically changing the fractional value in a deterministic way. The disadvantage of this approach is that there are often spurious components close to the fundamental signal. In the [ADRF6604](#), a Σ - Δ modulator is used to distribute the fractional value randomly, thus significantly reducing the spurious content due to the fractional function.

PROGRAMMING THE ADRF6604

The [ADRF6604](#) is programmed via a 3-pin SPI port. The timing requirements for the SPI port are shown in Figure 2. Eight programmable registers, each with 24 bits, control the operation of the device. The register functions are listed in Table 8.

Table 8. ADRF6604 Register Functions

Register	Function
Register 0	Integer divide control for the PLL
Register 1	Modulus divide control for the PLL
Register 2	Fractional divide control for the PLL
Register 3	Σ - Δ modulator dither control
Register 4	PLL charge pump, PFD, reference path control
Register 5	PLL enable and LO path control
Register 6	VCO control and VCO enable
Register 7	Mixer bias enable and external VCO enable

Note that internal calibration for the PLL must be run when the [ADRF6604](#) is initialized at a given frequency. This calibration is run automatically whenever Register 0, Register 1, or Register 2 is programmed. Because the other registers affect PLL performance, Register 0, Register 1, and Register 2 should always be programmed last and in the following order: Register 0, Register 1, Register 2.

To program the frequency of the [ADRF6604](#), the user typically programs only Register 0, Register 1, and Register 2. However, if registers other than these are programmed first, a short delay should be inserted before programming Register 0. This delay ensures that the VCO band calibration has sufficient time to complete before the final band calibration for Register 0 is initiated.

Software is available on the [ADRF6604](#) product page under the Evaluation Boards & Kits section that allows easy programming from a PC running Windows® XP or Vista.

INITIALIZATION SEQUENCE

To ensure proper power-up of the [ADRF6604](#), it is important to reset the PLL circuitry after the VCC supply rail settles to 5 V $\pm$ 0.25 V. Resetting the PLL ensures that the internal bias cells are properly configured, even under poor supply start-up conditions.

To ensure that the PLL is reset after power-up, use the following procedure:

1. Disable the PLL by setting the PLEN bit to 0 (Register 5, Bit DB6).
2. After a delay of >100 ms, set the PLEN bit to 1 (Register 5, Bit DB6).

After this procedure is completed, the other registers should be programmed in the following order: Register 7, Register 6, Register 4, Register 3, Register 2, Register 1. Then, after a delay of >100 ms, Register 0 should be programmed.

LO SELECTION LOGIC

The downconverting mixer in the [ADRF6604](#) can be used without the internal PLL by applying an external differential LO to Pin 37 (LON) and Pin 38 (LOP). In addition, when using an LO generated by the internal PLL, the LO signal can be accessed directly at these pins. This function can be used for debugging purposes, or the internally generated LO can be used as the LO for a separate mixer.

The operation of the LO generation and whether LOP and LON are inputs or outputs are determined by the logic levels applied at Pin 16 (PLL_EN) and Pin 36 (LODRV_EN), as well as Bit DB3 (LDRV) and Bit DB6 (PLEN) in Register 5. The combination of externally applied logic and internal bits required for particular LO functions is given in Table 9.

Table 9. LO Selection Logic

Pins ¹		Register 5 Bits ¹		Outputs	
Pin 16 (PLL_EN)	Pin 36 (LODRV_EN)	Bit DB6 (PLEN)	Bit DB3 (LDRV)	Output Buffer	LO
0	X	0	X	Disabled	External
0	X	1	X	Disabled	External
1	X	0	X	Disabled	External
1	0	1	0	Disabled	Internal
1	X	1	1	Enabled	Internal
1	1	1	X	Enabled	Internal

¹ X = don't care.

APPLICATIONS INFORMATION

BASIC CONNECTIONS FOR OPERATION

Figure 46 shows the basic connections for the ADRF6604 evaluation board. The six power supply pins should be individually decoupled using 100 pF and 0.1 μ F capacitors located as close as possible to the device. In addition, the internal decoupling nodes (DECL3P3, DECL2P5, and DECLVCO) should be decoupled with the capacitor values shown in Figure 46.

The RF input is internally ac-coupled and needs no external bias. The IF outputs are open collector, and a bias inductor is required from these outputs to VCC.

A peak-to-peak differential swing on RF_{IN} of 1 V (0.353 V rms for a sine wave input) results in an IF output power of 4.7 dBm.

The reference frequency for the PLL should be from 12 MHz to 160 MHz and should be applied to the REF_IN pin, which should

be ac-coupled and terminated with a 50 Ω resistor as shown in Figure 46. The reference signal, or a divided-down version of the reference signal, can be brought back off chip at the multiplexer output pin (MUXOUT). A lock detect signal and a voltage proportional to the ambient temperature can also be selected on the multiplexer output pin.

The loop filter is connected between the CP and VTUNE pins. When connected in this way, the internal VCO is operational. For information about the loop filter components, see the Evaluation Board Configuration Options section.

Operation with an external VCO is also possible. In this case, the loop filter components should be referred to ground. The output of the loop filter is connected to the input voltage pin of the external VCO. The output of the VCO is brought back into the device on the LOP and LON pins, using a balun if necessary.

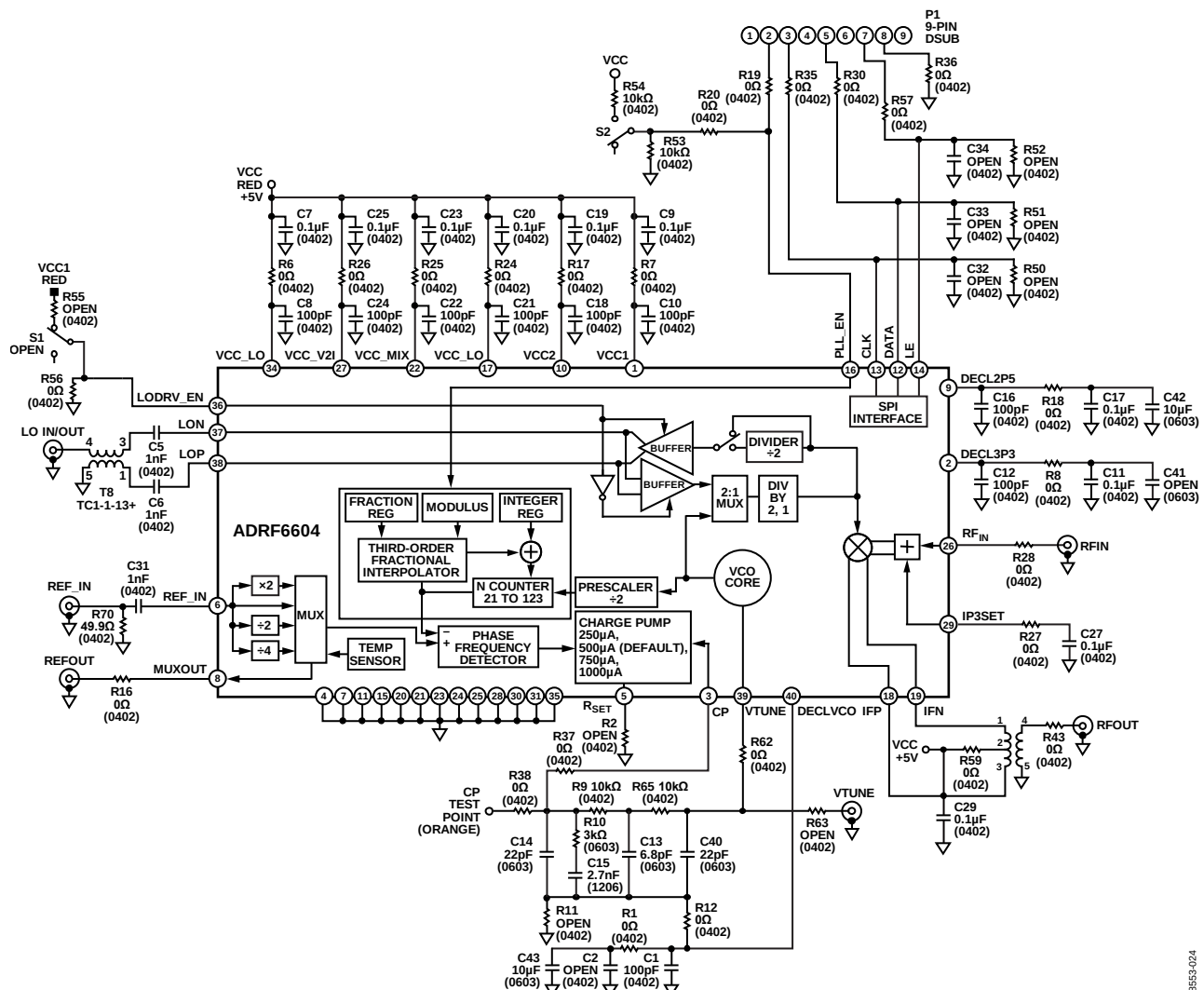


Figure 46. Basic Connections for Operation of the ADRF6604

AC TEST FIXTURE

Characterization data for the [ADRF6604](#) was taken under very strict test conditions. All possible techniques were used to achieve optimum accuracy and to remove degrading effects of

the signal generation and measurement equipment. Figure 47 shows the typical AC test setup used in the characterization of the [ADRF6604](#).

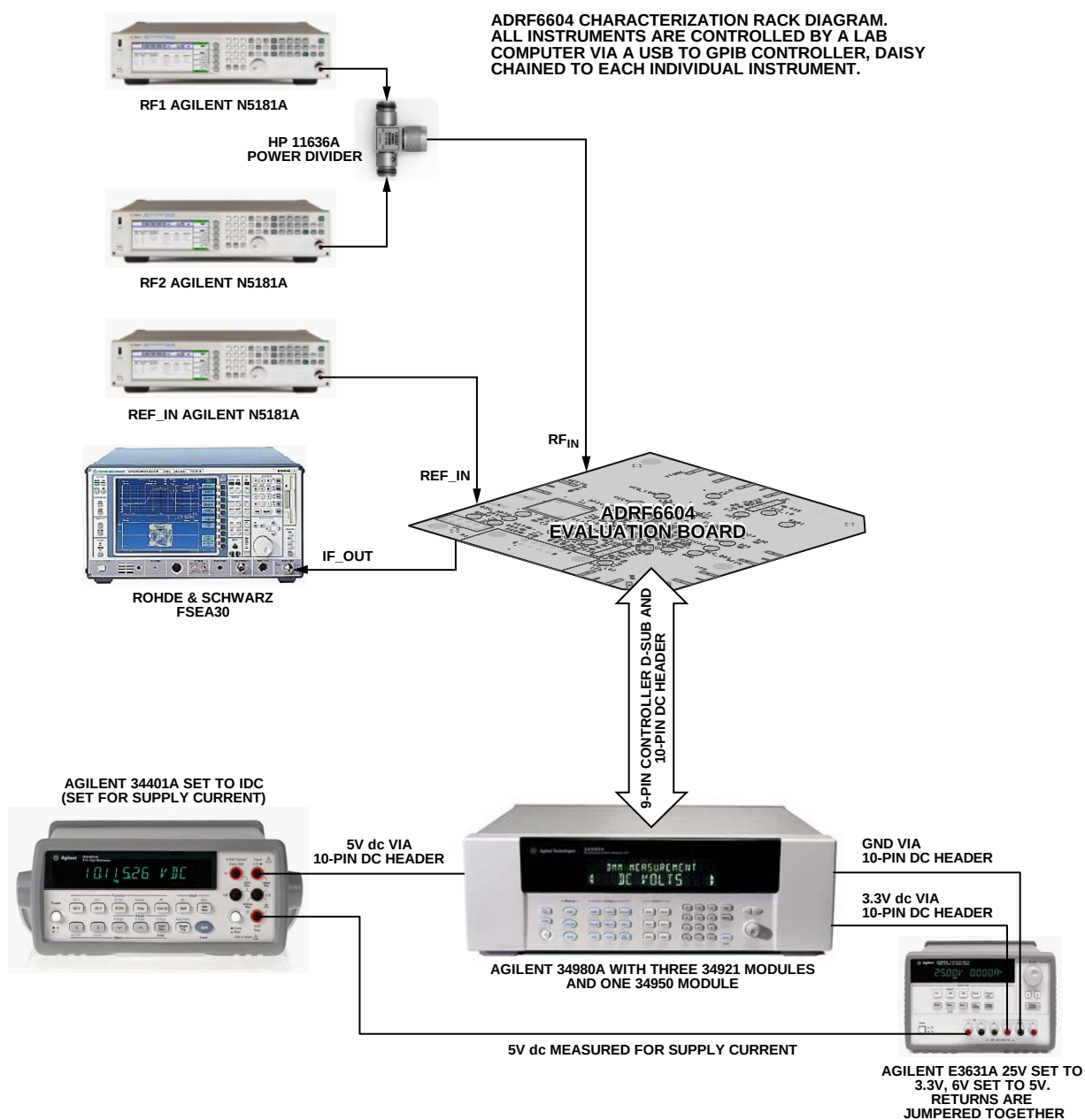


Figure 47. [ADRF6604](#) AC Test Setup

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EVALUATION BOARD

Figure 50 shows the schematic of the RoHS-compliant evaluation board for the [ADRF6604](#). This board has four layers and was designed using Rogers 4350 hybrid material to minimize high frequency losses. FR4 material is also adequate if the design can accept the slightly higher trace loss of this material.

The evaluation board is designed to operate using the internal VCO of the device (the default configuration) or using an external VCO. To use an external VCO, R62 and R12 should be removed. Place 0 Ω resistors in R63 and R11. The input of the external VCO should be connected to the VTUNE SMA connector, and the external VCO output should be connected to the LO IN/OUT SMA connector. In addition to these hardware changes, internal register settings must be changed to enable operation with an external VCO (see the Register 6—VCO Control and VCO Enable (Default: 0x1E2106) section).

Additional configuration options for the evaluation board are described in Table 10.

EVALUATION BOARD CONTROL SOFTWARE

Software to program the [ADRF6604](#) is available for download from the [ADRF6604](#) product page under the Evaluation Boards & Kits section. To install the software

1. Download and extract the zip file:
ADRF6x0x_customer_6p0p0_install.zip file.
2. Follow the instructions in the read me file.

The evaluation board can be connected to the PC using a PC parallel port or a USB port. These options are selectable from the opening menu of the software interface (see Figure 48). The evaluation board is shipped with a 25-pin parallel port cable for connection to the PC parallel port.

To connect the evaluation board to a USB port, a USB adapter board ([EVAL-ADF4XXXZ-USB](#)) must be purchased from Analog Devices. This board connects to the PC using a standard USB cable with a USB mini-connector at one end. An additional 25-pin male to 9-pin female adapter is required to mate the EVAL-ADF4XXXZ-USB board to the 9-pin D-Sub connector on the [ADRF6604](#) evaluation board.

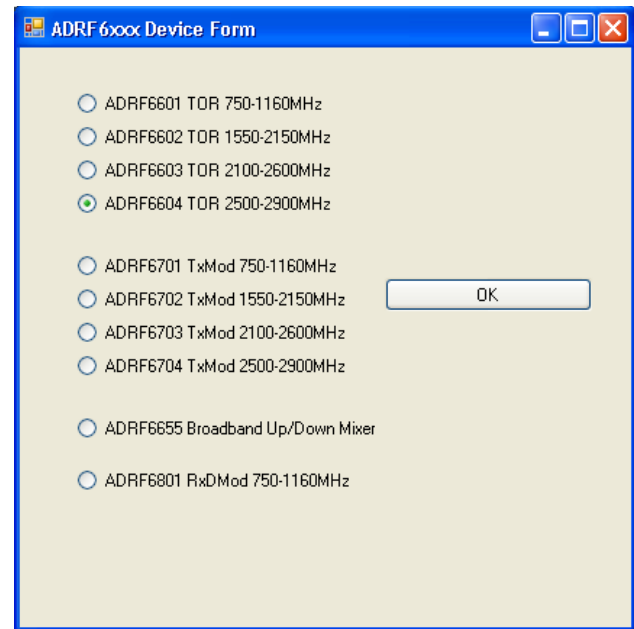


Figure 48. Control Software Opening Menu

Figure 49 shows the main window of the control software with the default settings displayed.

Analog Devices ADRF6x0x Customer Evaluation Software v6.0.0 - ADRF6604 TOR 2500-2900MHz

Device

LO Path and Modulator Control

LO Output Driver Disabled

Mixer LO Source - Internal VCO

PLL Enabled

RF Section

Divide Mode: Fractional

Ref Input Frequency: 38.4 MHz

PFD Frequency: 38.4 MHz

Modulus: 1536

VCO Frequency(2xLO): 5200

LO Frequency: 2600 MHz

Channel Step Size: 25 kHz

Charge Pump (CP)

Current Reference Source: Internal(250uA)

Current Multiplier: x2

CP Current (uA)= 500uA

Charge Pump Control: Hi-Z

CP Control Source: PFD

PFD Phase Offset Multiplier (0-31): 10 x 22.5°/CP current multiplier

PFD Phase Offset Polarity: positive

PFD Phase Offset: 112.5°

Output Reference Mux Source

Lock Detect

SDM Dither Control

Dither Restart Value: 1

SDM Dither Enable: Dither En

SDM Dither Magnitude: 1

VCO Band Select from SPI: 32

VCO Amplitude Setting: 55

VCO Band Select and SW Source: Band Cal

VCO Controls and Enables

VCO Enable: Enable

VCO LDO Enable: Enable

3.3V LDO Enable: Enable

Charge Pump Enable: Enable

External VCO Enable: Disable

VCO Switch Control from SPI: Regular

PFD

PFD Divider Path Edge Sensitivity: Falling Edge

PFD Reference Path Edge Sensitivity: Rising Edge

PFD Anti Backlash Delay: 0 nsec

Cap DAC Value: 0

Spare (R7) Value: 0

To be Loaded in Registers on Next Update

MSB	Binary	LSB	Hex
0000	0000 0000 0010 0001 1 000		000218
0000	0000 0011 0000 0000 0 001		003001
0000	0000 0010 0010 0000 0 010		002202
0111	0000 0000 0000 0000 1 011		70000b

ADRF6x0x eval board connected

All Registers Updated

R0 Updated R4 Updated

R1 Updated R5 Updated

R2 Updated R6 Updated

R3 Updated R7 Updated

To be Loaded in Registers on Next Update

MSB	Binary	LSB	Hex
0000	1010 1010 0111 1010 0 100		0aa7a4
0000	0000 0000 0000 0110 0 101		000065
0001	1110 1101 1101 0000 0 110		1edd06
0000	0000 0000 0000 0000 0 111		000007

ANALOG DEVICES

Figure 49. Main Window of the ADRF6604 Evaluation Board Software

SCHEMATIC AND ARTWORK

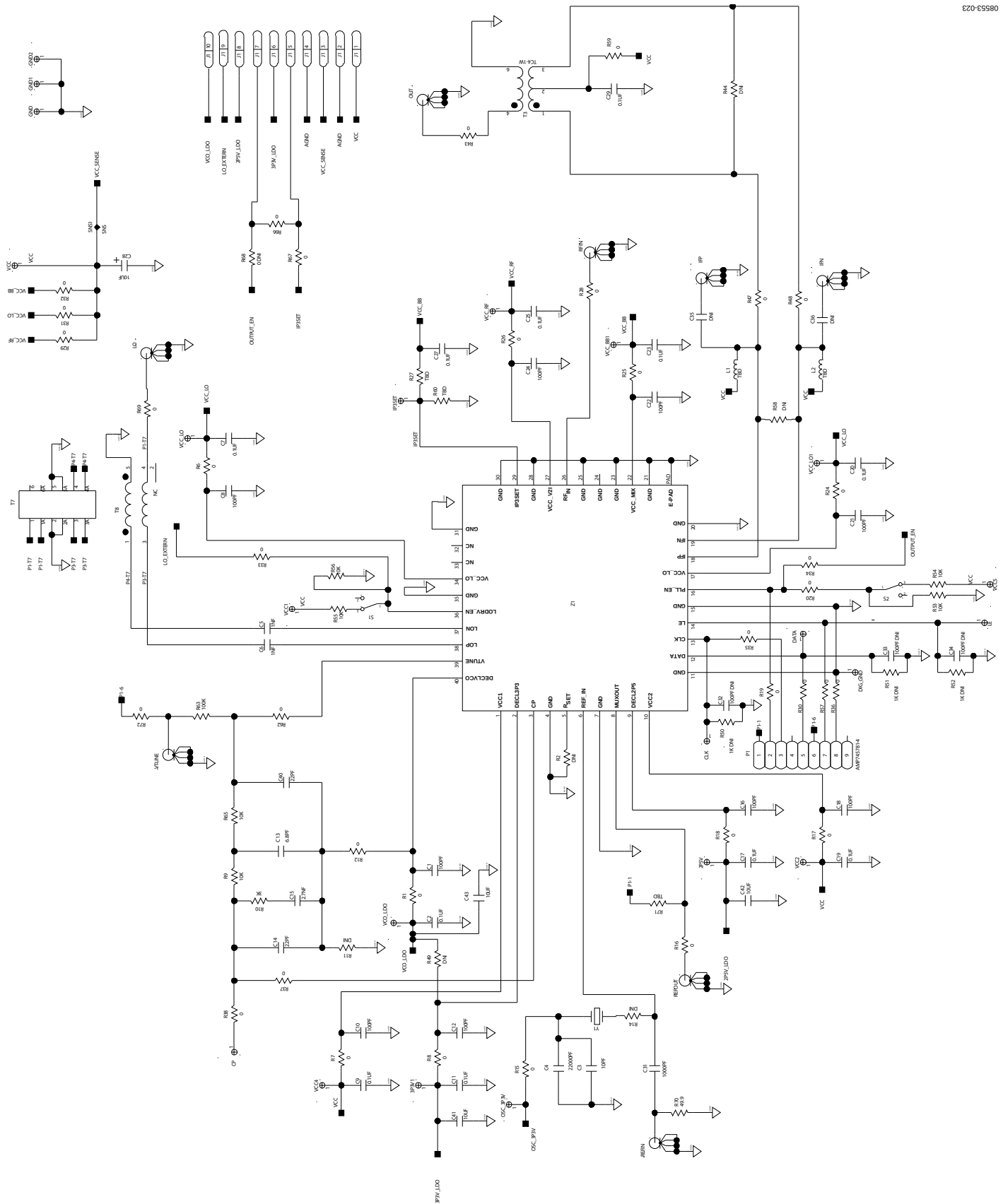
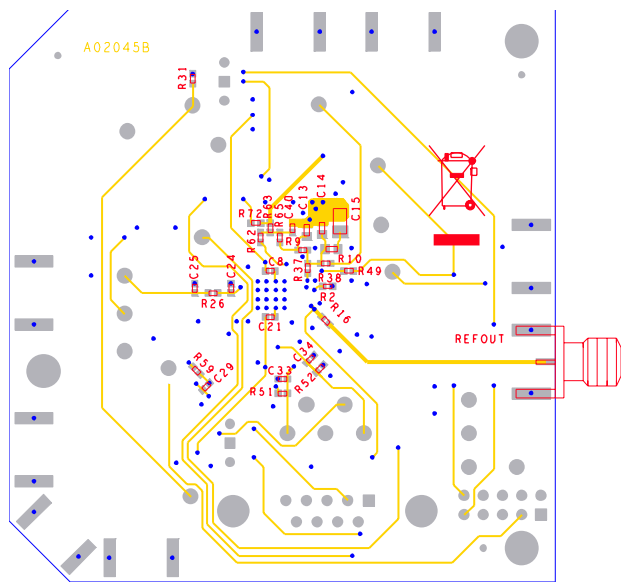
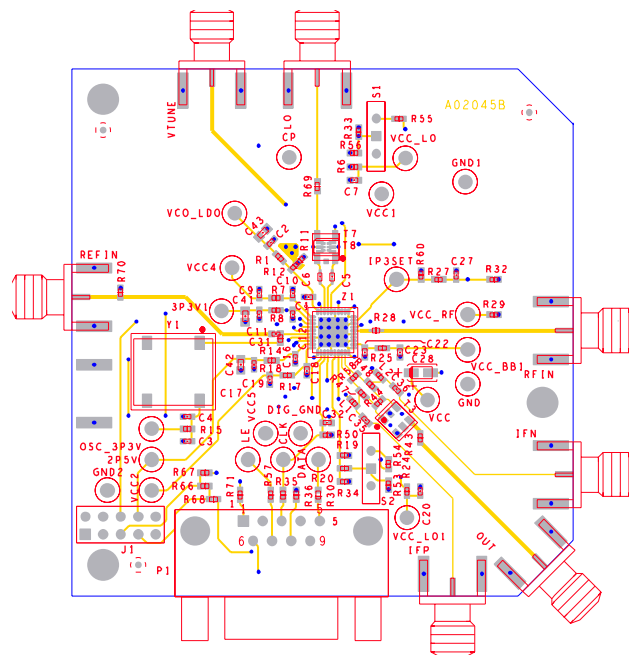


Figure 50. Evaluation Board Schematic



08553-013

Figure 51. Evaluation Board Layout (Bottom)



08553-012

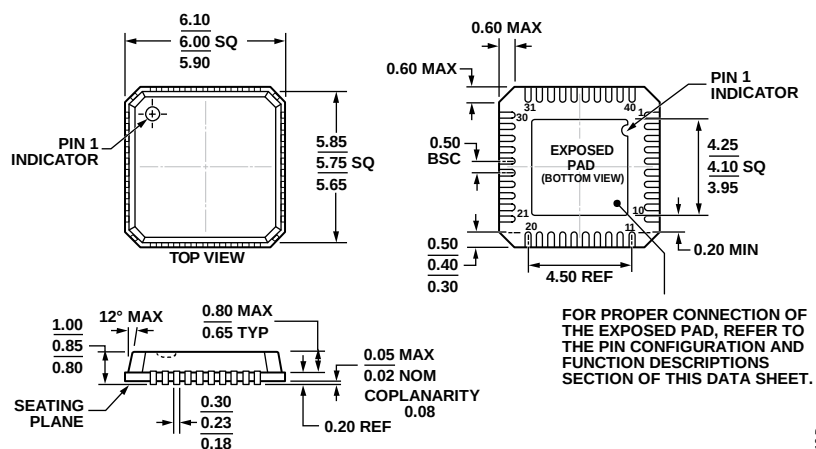
Figure 52. Evaluation Board Layout (Top)

EVALUATION BOARD CONFIGURATION OPTIONS

Table 10.

Component	Description	Default Condition/ Option Settings
S1, R55, R56, R33	LO select. Switch and resistors to ground the LODRV_EN pin. The LODRV_EN pin setting, in combination with internal register settings, determines whether the LOP and LON pins function as inputs or outputs (see the LO Selection Logic section for more information).	S1 = R55 = open (not installed), R56 = R33 = 0 Ω , LODRV_EN = 0 V
LO IN/OUT SMA Connector	LO input/output. An external 1 $\times$ LO or 2 $\times$ LO can be applied to this single-ended input connector.	LO input
REFIN SMA Connector	Reference input. The input reference frequency for the PLL is applied to this connector. Input impedance is 50 Ω .	
REFOUT SMA Connector	Multiplexer output. The REFOUT connector connects directly to the MUXOUT pin. The on-board multiplexer can be programmed to bring out the following signals: REFIN, 2 $\times$ REFIN, REFIN/2, and REFIN/4; temperature sensor output voltage; and lock detect indicator.	Lock detect
CP Test Point	Charge pump test point. The unfiltered charge pump signal can be probed at this test point. Note that the CP pin should not be probed during critical measurements, such as phase noise.	
R37, C14, R9, R10, C15, C13, R65, C40	Loop filter. Loop filter components.	
R11, R12	Loop filter return. When the internal VCO is used, the loop filter components should be returned to the DECLVCO pin (Pin 40) by installing a 0 Ω resistor in R12. When an external VCO is used, the loop filter components can be returned to ground by installing a 0 Ω resistor in R11.	R12 = 0 Ω (0402), R11 = open (0402)
R62, R63, VTUNE SMA Connector	Internal vs. external VCO. When the internal VCO is enabled, the loop filter components are connected directly to the VTUNE pin (Pin 39) by installing a 0 Ω resistor in R62. To use an external VCO, R62 should be left open. A 0 Ω resistor should be installed in R63, and the voltage input of the VCO should be connected to the VTUNE SMA connector. The output of the VCO is brought back into the PLL via the LO IN/OUT SMA connector.	R62 = 0 Ω (0402), R63 = open (0402)
R2	R _{SET} pin. This pin is unused and should be left open.	R2 = open (0402)
RFIN SMA Connector	RF input. The RF input signal should be applied to the RFIN SMA connector. The RF input of the ADRF6604 is ac-coupled; therefore, no bias is necessary.	R3 = R23 = open (0402)
T3	IF output. The differential IF output signals from the ADRF6604 (IFP and IFN) are converted to a single-ended signal by T3.	

OUTLINE DIMENSIONS



06-01-2012-D

ORDERING GUIDE

Model ¹	Temperature Range	Package Description	Package Option
ADRF6604ACPZ-R7	−40°C to +85°C	40-Lead Lead Frame Chip Scale Package [LFCSP_VQ]	CP-40-1
ADRF6604-EVALZ		Evaluation Board	

¹ Z = RoHS Compliant Part.

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**Стандарт
Электрон
Связь**

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